

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/598,230 HEKSTRA ET AL.	
		Examiner	Art Unit RICKY CHIN	2423 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0036782 A1	02-2004	Knapp, Verna	348/239
	B	US-			
	C	US-			
	D	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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